

### FEATURES

**+1.8 V to +5.5 V Single Supply**  
**2.5  $\Omega$  (Typ) On Resistance**  
**Low On-Resistance Flatness**  
**-3 dB Bandwidth >200 MHz**  
**Rail-to-Rail Operation**  
**10-Lead  $\mu$ SOIC Package**  
**Fast Switching Times**  
 $t_{ON}$  20 ns  
 $t_{OFF}$  13 ns  
**Typical Power Consumption (<0.01  $\mu$ W)**  
**TTL/CMOS Compatible**

### APPLICATIONS

**Battery Powered Systems**  
**Communication Systems**  
**Sample-and-Hold Systems**  
**Audio Signal Routing**  
**Data Acquisition System**  
**Video Switching**

### GENERAL DESCRIPTION

The ADG704 is a CMOS analog multiplexer, comprising four single channels. This multiplexer is designed on an advanced submicron process that provides low power dissipation yet gives high switching speed, low on resistance, low leakage currents and high bandwidths.

The on resistance profile is very flat over the full analog signal range. This ensures excellent linearity and low distortion when switching audio signals. Fast switching speed also makes the part suitable for video signal switching.

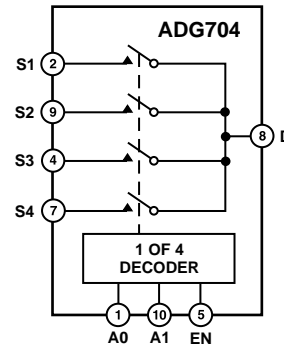
The ADG704 can operate from a single supply range of +1.8 V to +5.5 V, making it ideal for use in battery powered instruments and with the new generation of DACs and ADCs from Analog Devices.

The ADG704 switches one of four inputs to a common output, D, as determined by the 3-bit binary address lines, A0, A1 and EN. A Logic "0" on the EN pin disables the device.

Each switch of the ADG704 conducts equally well in both directions when ON. The ADG704 exhibits break-before-make switching action.

The ADG704 is available in 10-lead  $\mu$ SOIC package.

### FUNCTIONAL BLOCK DIAGRAM



### PRODUCT HIGHLIGHTS

- +1.8 V to +5.5 V Single Supply Operation.  
The ADG704 offers high performance and is fully specified and guaranteed with +3 V and +5 V supply rails.
- Very Low  $R_{ON}$  (4.5  $\Omega$  Max at 5 V, 8  $\Omega$  Max at 3 V).  
At supply voltage of +1.8 V,  $R_{ON}$  is typically 35  $\Omega$  over the temperature range.
- Low On-Resistance Flatness.
- 3 dB Bandwidth Greater than 200 MHz.
- Low Power Dissipation.  
CMOS construction ensures low power dissipation.
- Fast  $t_{ON}/t_{OFF}$ .
- Break-Before-Make Switching Action.
- 10-Lead  $\mu$ SOIC Package.

### REV. A

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# ADG704—SPECIFICATIONS<sup>1</sup> ( $V_{DD} = +5\text{ V} \pm 10\%$ , $GND = 0\text{ V}$ . All Specifications $-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ , unless otherwise noted.)

Parameter	B Version		Units	Test Conditions/Comments
	+25°C	-40°C to +85°C		
<b>ANALOG SWITCH</b>				
Analog Signal Range		0 V to $V_{DD}$	V	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$ ; Test Circuit 1
On-Resistance ( $R_{ON}$ )	2.5		$\Omega$ typ	
	4	4.5	$\Omega$ max	
On-Resistance Match Between Channels ( $\Delta R_{ON}$ )		0.1	$\Omega$ typ	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$
		0.4	$\Omega$ max	
On-Resistance Flatness ( $R_{FLAT(ON)}$ )	0.75		$\Omega$ typ	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$
		1.2	$\Omega$ max	
<b>LEAKAGE CURRENTS</b>				
Source OFF Leakage $I_S$ (OFF)	$\pm 0.01$		nA typ	$V_{DD} = +5.5\text{ V}$ $V_S = 4.5\text{ V}/1\text{ V}$ , $V_D = 1\text{ V}/4.5\text{ V}$ ; Test Circuit 2
	$\pm 0.1$	$\pm 0.3$	nA max	
Drain OFF Leakage $I_D$ (OFF)	$\pm 0.01$		nA typ	$V_S = 4.5\text{ V}/1\text{ V}$ , $V_D = 1\text{ V}/4.5\text{ V}$ ; Test Circuit 2
	$\pm 0.1$	$\pm 0.3$	nA max	
Channel ON Leakage $I_D$ , $I_S$ (ON)	$\pm 0.01$		nA typ	$V_S = V_D = 4.5\text{ V}$ or $1\text{ V}$ ; Test Circuit 3
	$\pm 0.1$	$\pm 0.3$	nA max	
<b>DIGITAL INPUTS</b>				
Input High Voltage, $V_{INH}$		2.4	V min	$V_{IN} = V_{INL}$ or $V_{INH}$
Input Low Voltage, $V_{INL}$		0.8	V max	
Input Current				
$I_{INL}$ or $I_{INH}$	0.005	$\pm 0.1$	$\mu\text{A}$ typ $\mu\text{A}$ max	
<b>DYNAMIC CHARACTERISTICS<sup>2</sup></b>				
$t_{ON}$	14		ns typ	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_S = 3\text{ V}$ , Test Circuit 4
		20	ns max	
$t_{OFF}$	6		ns typ	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_S = 3\text{ V}$ , Test Circuit 4
		13	ns max	
Break-Before-Make Time Delay, $t_D$	8		ns typ	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_{S1} = V_{S2} = 3\text{ V}$ , Test Circuit 5
		1	ns min	
Charge Injection	3		pC typ	$V_S = 2\text{ V}$ , $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ ; Test Circuit 6
Off Isolation	-60		dB typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 10\text{ MHz}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ ; Test Circuit 7
	-80		dB typ	
Channel-to-Channel Crosstalk	-62		dB typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 10\text{ MHz}$ $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ ; Test Circuit 8
	-82		dB typ	
Bandwidth -3 dB	200		MHz typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ ; Test Circuit 9
$C_S$ (OFF)	9		pF typ	
$C_D$ (OFF)	37		pF typ	
$C_D$ , $C_S$ (ON)	54		pF typ	
<b>POWER REQUIREMENTS</b>				
$I_{DD}$	0.001		$\mu\text{A}$ typ	$V_{DD} = +5.5\text{ V}$ Digital Inputs = $0\text{ V}$ or $5\text{ V}$
		1.0	$\mu\text{A}$ max	

## NOTES

<sup>1</sup>Temperature ranges are as follows: B Version:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .

<sup>2</sup>Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

# SPECIFICATIONS<sup>1</sup> ( $V_{DD} = +3\text{ V} \pm 10\%$ , $GND = 0\text{ V}$ . All Specifications $-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ , unless otherwise noted.)

Parameter	B Version		Units	Test Conditions/Comments
	+25°C	-40°C to +85°C		
<b>ANALOG SWITCH</b>				
Analog Signal Range		0 V to $V_{DD}$	V	
On-Resistance ( $R_{ON}$ )	4.5	5 8	$\Omega$ typ $\Omega$ max	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$ ; Test Circuit 1
On-Resistance Match Between Channels ( $\Delta R_{ON}$ )	0.1		$\Omega$ typ $\Omega$ max	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$
On-Resistance Flatness ( $R_{FLAT(ON)}$ )		0.4 2.5	$\Omega$ max $\Omega$ typ	$V_S = 0\text{ V}$ to $V_{DD}$ , $I_{DS} = -10\text{ mA}$
<b>LEAKAGE CURRENTS</b>				
Source OFF Leakage $I_S$ (OFF)	$\pm 0.01$		nA typ nA max	$V_{DD} = +3.3\text{ V}$ $V_S = 3\text{ V}/1\text{ V}$ , $V_D = 1\text{ V}/3\text{ V}$ ; Test Circuit 2
Drain OFF Leakage $I_D$ (OFF)	$\pm 0.01$	$\pm 0.3$	nA typ nA max	$V_S = 3\text{ V}/1\text{ V}$ , $V_D = 1\text{ V}/3\text{ V}$ ; Test Circuit 2
Channel ON Leakage $I_D$ , $I_S$ (ON)	$\pm 0.01$	$\pm 0.3$	nA typ nA max	$V_S = V_D = 3\text{ V}$ or $1\text{ V}$ ; Test Circuit 3
<b>DIGITAL INPUTS</b>				
Input High Voltage, $V_{INH}$		2.0	V min	
Input Low Voltage, $V_{INL}$		0.4	V max	
Input Current $I_{INL}$ or $I_{INH}$	0.005	$\pm 0.1$	$\mu\text{A}$ typ $\mu\text{A}$ max	$V_{IN} = V_{INL}$ or $V_{INH}$
<b>DYNAMIC CHARACTERISTICS<sup>2</sup></b>				
$t_{ON}$	16	24	ns typ ns max	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_S = 2\text{ V}$ , Test Circuit 4
$t_{OFF}$	8	16	ns typ ns max	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_S = 2\text{ V}$ , Test Circuit 4
Break-Before-Make Time Delay, $t_D$	9	1	ns typ ns min	$R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ $V_{S1} = V_{S2} = 2\text{ V}$ , Test Circuit 5
Charge Injection	3		pC typ	$V_S = 1.5\text{ V}$ , $R_S = 0\ \Omega$ , $C_L = 1\text{ nF}$ ; Test Circuit 6
Off Isolation	-60 -80		dB typ dB typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 10\text{ MHz}$ ; $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ ; Test Circuit 7
Channel-to-Channel Crosstalk	-62 -82		dB typ dB typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 10\text{ MHz}$ ; $R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ , $f = 1\text{ MHz}$ ; Test Circuit 8
Bandwidth -3 dB	200		MHz typ	$R_L = 50\ \Omega$ , $C_L = 5\text{ pF}$ ; Test Circuit 9
$C_S$ (OFF)	9		pF typ	
$C_D$ (OFF)	37		pF typ	
$C_D$ , $C_S$ (ON)	54		pF typ	
<b>POWER REQUIREMENTS</b>				
$I_{DD}$	0.001	1.0	$\mu\text{A}$ typ $\mu\text{A}$ max	$V_{DD} = +3.3\text{ V}$ Digital Inputs = 0 V or 3 V

## NOTES

<sup>1</sup>Temperature ranges are as follows: B Version:  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ .<sup>2</sup>Guaranteed by design, not subject to production test.

Specifications subject to change without notice.

# ADG704

## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

(T<sub>A</sub> = +25°C unless otherwise noted)

V <sub>DD</sub> to GND	.....	-0.3 V to +6 V
Analog, Digital Inputs <sup>2</sup>	.....	-0.3 V to V <sub>DD</sub> +0.3 V or 30 mA, Whichever Occurs First
Continuous Current, S or D	.....	30 mA
Peak Current, S or D	.....	100 mA (Pulsed at 1 ms, 10% Duty Cycle Max)
Operating Temperature Range		
Industrial (B Version)	.....	-40°C to +85°C
Storage Temperature Range	.....	-65°C to +150°C
Junction Temperature	.....	+150°C
μSOIC Package, Power Dissipation	.....	315 mW
θ <sub>JA</sub> Thermal Impedance	.....	206°C/W
Lead Temperature, Soldering		
Vapor Phase (60 sec)	.....	+215°C
Infrared (15 sec)	.....	+220°C
ESD	.....	2 kV

### NOTES

<sup>1</sup>Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

<sup>2</sup>Overvoltages at IN, S or D will be clamped by internal diodes. Current should be limited to the maximum ratings given.

## ORDERING GUIDE

Model	Temperature Range	Brand <sup>1</sup>	Package Option <sup>2</sup>
ADG704BRM	-40°C to +85°C	S9B	RM-10

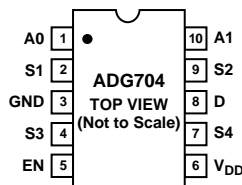
### NOTES

<sup>1</sup>Brand = Due to small package size, these three characters represent the part number.

<sup>2</sup>RM = μSOIC.

## PIN CONFIGURATION

(10-Lead μSOIC)



## TERMINOLOGY

V <sub>DD</sub>	Most positive power supply potential.
GND	Ground (0 V) reference.
S	Source terminal. May be an input or output.
D	Drain terminal. May be an input or output.
A0, A1	Logic control inputs.
EN	Logic control input.
R <sub>ON</sub>	Ohmic resistance between D and S.
ΔR <sub>ON</sub>	On resistance match between any two channels i.e., R <sub>ONmax</sub> -R <sub>ONmin</sub> .
R <sub>FLAT(ON)</sub>	Flatness is defined as the difference between the maximum and minimum value of on resistance as measured over the specified analog signal range.
I <sub>D</sub> (OFF)	Drain leakage current with the switch "OFF."
I <sub>S</sub> (OFF)	Source leakage current with the switch "OFF."
I <sub>D</sub> , I <sub>S</sub> (ON)	Channel leakage current with the switch "ON."
V <sub>D</sub> (V <sub>S</sub> )	Analog voltage on terminals D, S.
C <sub>S</sub> (OFF)	"OFF" switch source capacitance.
C <sub>D</sub> (OFF)	"OFF" switch drain capacitance.
C <sub>D</sub> , C <sub>S</sub> (ON)	"ON" switch capacitance.
t <sub>ON</sub>	Delay between applying the digital control input and the output switching on. See Test Circuit 4.
t <sub>OFF</sub>	Delay between applying the digital control input and the output switching off.
t <sub>D</sub>	"OFF" time or "ON" time measured between the 90% points of both switches, when switching from one address state to another. See Test Circuit 5.
Crosstalk	A measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.
Off Isolation	A measure of unwanted signal coupling through an "OFF" switch.
Charge Injection	A measure of the glitch impulse transferred from the digital input to the analog output during switching.
Bandwidth	The frequency at which the output is attenuated by -3 dBs.
On Response	The frequency response of the "ON" switch.
On Loss	The voltage drop across the "ON" switch, seen on the On Response vs. Frequency plot as how many dBs the signal is away from 0 dB at very low frequencies.

Table I. Truth Table

A1	A0	EN	ON Switch
X	X	0	NONE
0	0	1	1
0	1	1	2
1	0	1	3
1	1	1	4

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADG704 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



# Typical Performance Characteristics—ADG704

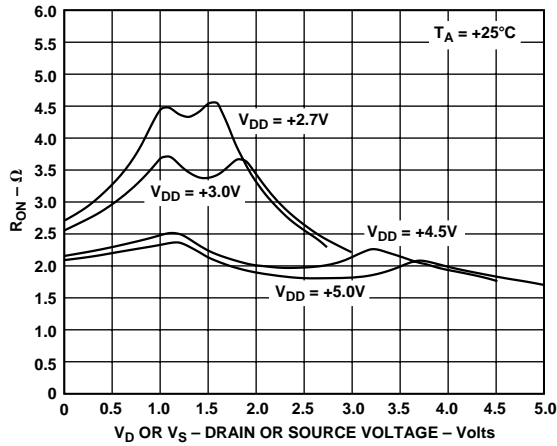


Figure 1. On Resistance as a Function of  $V_D$  ( $V_S$ ) Single Supplies

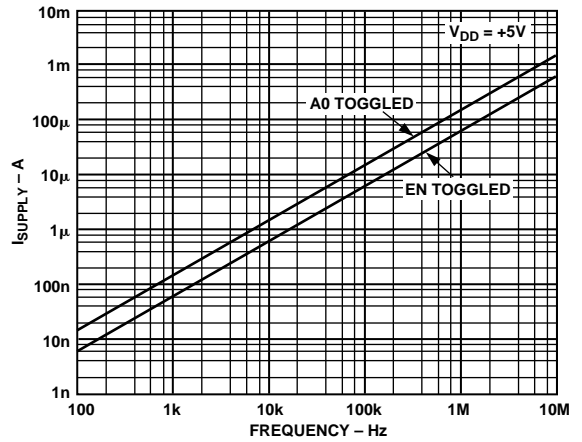


Figure 4. Supply Current vs. Input Switching Frequency

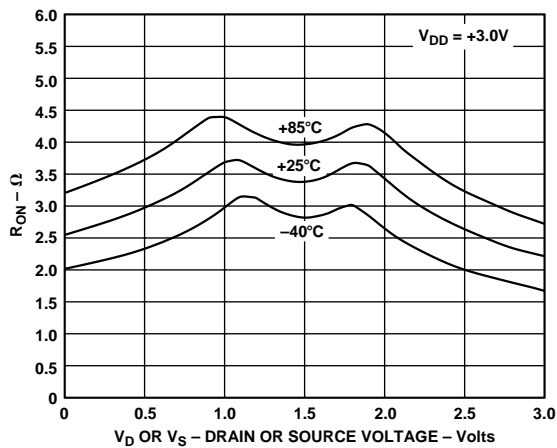


Figure 2. On Resistance as a Function of  $V_D$  ( $V_S$ ) for Different Temperatures;  $V_{DD} = 3\text{ V}$

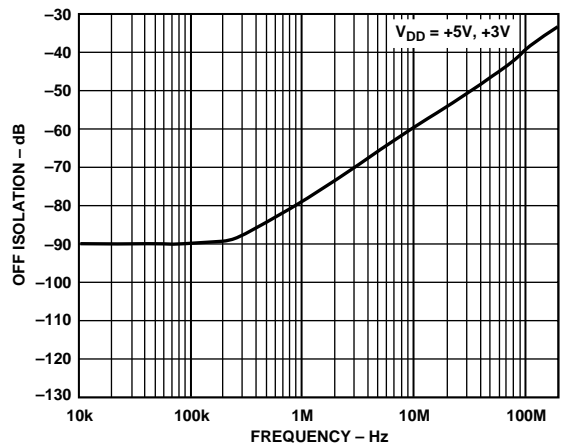


Figure 5. Off Isolation vs. Frequency

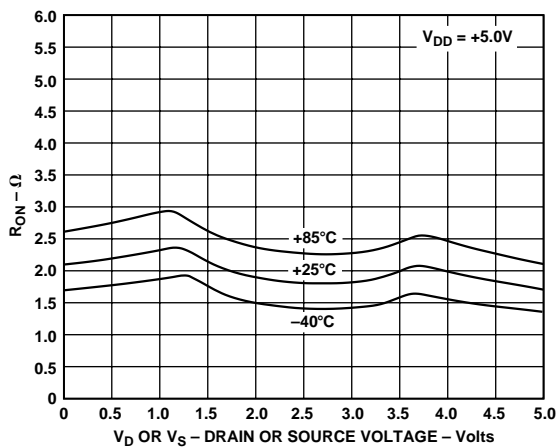


Figure 3. On Resistance as a Function of  $V_D$  ( $V_S$ ) for Different Temperatures;  $V_{DD} = 5\text{ V}$

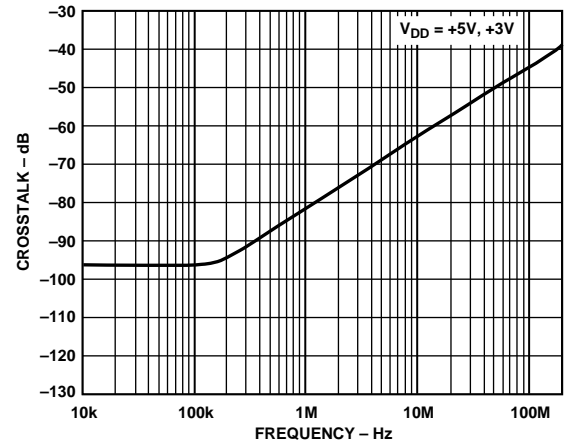


Figure 6. Crosstalk vs. Frequency

# ADG704



Figure 7. On Response vs. Frequency



Figure 8. Charge Injection vs. Source Voltage

## APPLICATIONS

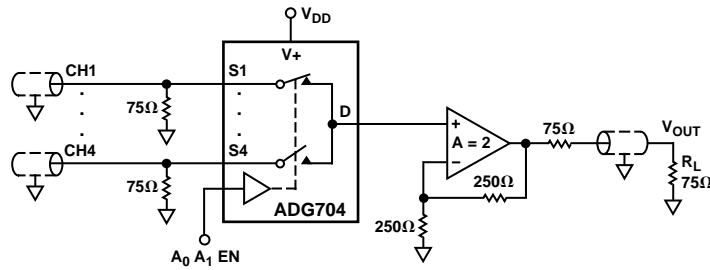
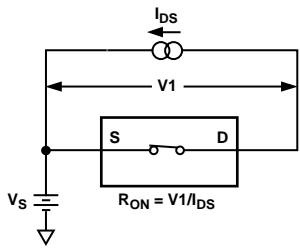
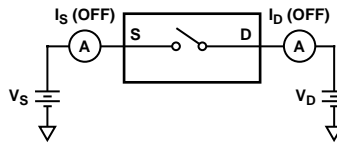


Figure 9. 4-Channel Video Multiplexing

# Test Circuits



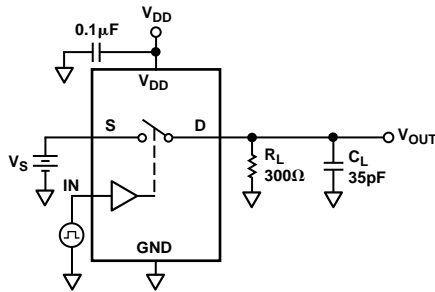
Test Circuit 1. On Resistance



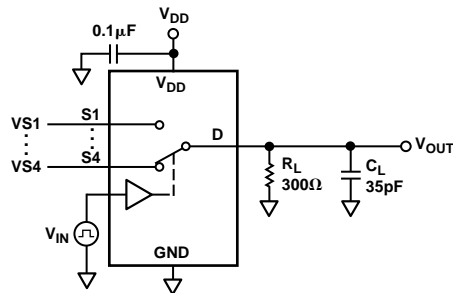
Test Circuit 2. Off Leakage



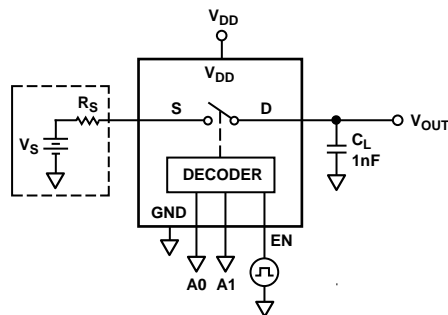
Test Circuit 3. On Leakage



Test Circuit 4. Switching Times

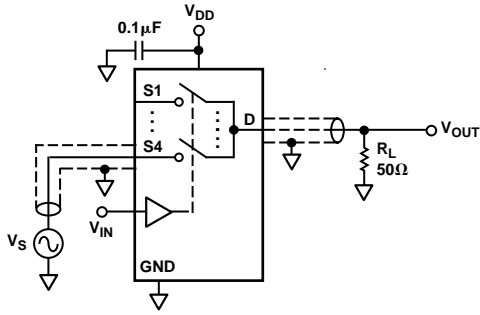


Test Circuit 5. Break-Before-Make Time Delay,  $t_D$

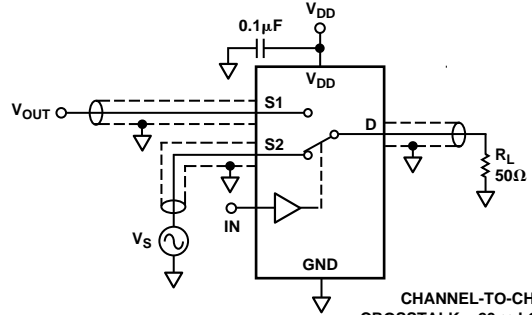


Test Circuit 6. Charge Injection

# ADG704

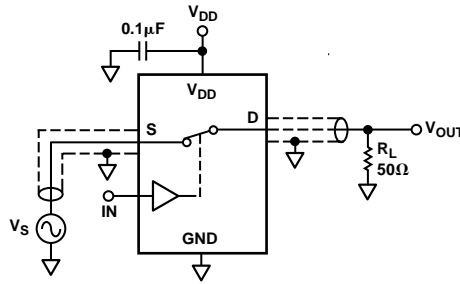


Test Circuit 7. Off Isolation



CHANNEL-TO-CHANNEL  
CROSSTALK =  $20 \times \text{LOG} |V_S/V_{OUT}|$

Test Circuit 8. Channel-to-Channel Crosstalk

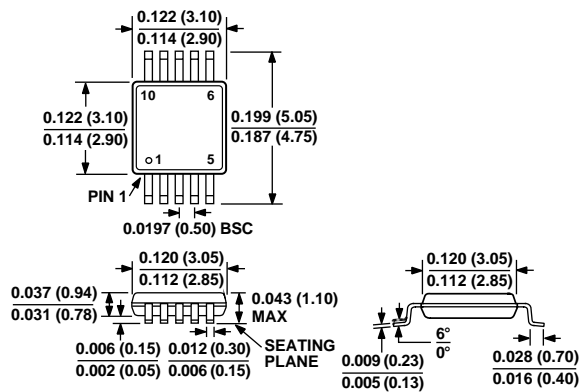


Test Circuit 9. Bandwidth

## OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

### 10-Lead $\mu$ SOIC (RM-10)





Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «**JONHON**», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «**FORSTAR**».



## JONHON

«**JONHON**» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«**FORSTAR**» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели,  
кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



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